

Notice of References Cited	Application/Control No. 10/604,594	Applicant(s)/Patent Under Reexamination AKATSU ET AL.	
	Examiner Khiem D. Nguyen	Art Unit 2823	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,359,300	03-2002	Economikos et al.	257/301
*	B	US-6,872,620	03-2005	Chidambarrao et al.	438/243
*	C	US-6,362,040	03-2002	Tews et al.	438/246
*	D	US-6,723,611	04-2004	Akatsu et al.	438/386
*	E	US-6,872,620	03-2005	Chidambarrao et al.	438/243
*	F	US-6,905,944	06-2005	Chudzik et al.	438/435
*	G	US-2004/0197965	10-2004	Birner et al.	438/149
*	H	US-6,762,099	07-2004	Yu-Sheng et al.	438/270
*	I	US-6,716,696	04-2004	Chen et al.	438/243
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.